



FQB9N50CF 500V N-Channel MOSFET

Features

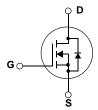
- 9A, 500V, $R_{DS(on)} = 0.85 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 28nC)
- · Low Crss (typical 24pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.





Absolute Maximum Ratings

| Symbol | Parameter | | FQB9N50CF | Units | |
|-----------------------------------|---|----------|-------------|-------|--|
| V _{DSS} | Drain-Source Voltage | | 500 | V | |
| I _D | Drain Current - Continuous (T _C = 25°C) | | 9 | Α | |
| | - Continuous (T _C = 100°C) | | 5.7 | Α | |
| I _{DM} | Drain Current - Pulsed | (Note 1) | 36 | Α | |
| V _{GSS} | Gate-Source Voltage | | ± 30 | V | |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | 300 | mJ | |
| I _{AR} | Avalanche Current | (Note 1) | 5 | Α | |
| E _{AR} | Repetitive Avalanche Energy (Note 1) | | 9.6 | mJ | |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | | 4.5 | V/ns | |
| P _D | Power Dissipation (T _C = 25°C) | | 173 | W | |
| | - Derate above 25°C | | 1.38 | W/°C | |
| T _J , T _{STG} | Operating and Storage Temperature Range | | -55 to +150 | °C | |
| T _L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | °C | |

Thermal Characteristics

| Symbol | Parameter | FQB9N50CF | Units |
|-----------------|--|-----------|-------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | 0.72 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient* | 40 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5 | °C/W |

 $^{^{\}star}$ When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------------|---------|-----------|------------|----------|
| FQB9N50CF | FQB9N50CFTM | D2-PAK | 330mm | 24mm | 800 |
| FQB9N50CFS | FQB9N50CFTM_WS | D2-PAK | 330mm | 24mm | 800 |

Electrical Characteristics T_C = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------|---|---|-----|------|------|-------|
| Off Charac | teristics | | | ' | ' | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V_{GS} = 0 V, I_{D} = 250 μ A | 500 | | | V |
| $\Delta BV_{DSS}/$ ΔT_J | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | | 0.57 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 500 V, V _{GS} = 0 V | | | 10 | μΑ |
| | | V _{DS} = 400 V, T _C = 125°C | | | 100 | μΑ |
| I _{GSSF} | Gate-Body Leakage Current, Forward | V _{GS} = 30 V, V _{DS} = 0 V | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | V _{GS} = -30 V, V _{DS} = 0 V | | | -100 | nA |
| On Charact | eristics | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 2.0 | | 4.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10 V, I _D = 4.5A | | 0.7 | 0.85 | Ω |
| 9 _{FS} | Forward Transconductance | V _{DS} = 40 V, I _D = 4.5 A (Note 4) | | 6.5 | | S |
| Dynamic Ch | haracteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ | | 790 | 1030 | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 130 | 170 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 24 | 30 | pF |
| Switching C | Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 250 V, I _D = 9A, | | 18 | 45 | ns |
| t _r | Turn-On Rise Time | $R_G = 25 \Omega$ | | 65 | 140 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 93 | 195 | ns |
| t _f | Turn-Off Fall Time | (Note 4, 5) | | 64 | 125 | ns |
| Qg | Total Gate Charge | V _{DS} = 400 V, I _D = 9A, | | 28 | 35 | nC |
| Q_{gs} | Gate-Source Charge | V _{GS} = 10 V | | 4 | | nC |
| Q_{gd} | Gate-Drain Charge | (Note 4, 5) | | 15 | | nC |
| Drain-Source | ce Diode Characteristics and Maximum Ratings | | | | | |
| I _S | Maximum Continuous Drain-Source Diode Forward Current | | | | 9 | Α |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | | | 36 | Α |
| V_{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 9 A | | | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _S = 9 A, | | 100 | | ns |
| Q _{rr} | Reverse Recovery Charge | $dI_F / dt = 100 A/\mu s$ (Note 4) | | 300 | | nC |

NOTES:

- 1. Repetitive Rating : Pulse width limited by maximum junction temperature
- 2. L = 8mH, I $_{AS}$ = 9A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C
- 3. $I_{SD} \le 9A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test : Pulse width $\leq 300 \mu s,$ Duty cycle $\leq 2\%$
- 5. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. On-Region Characteristics

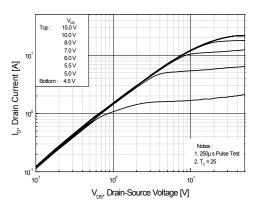


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

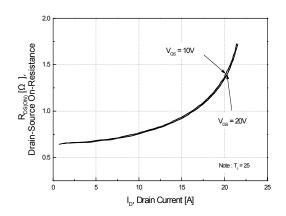


Figure 5. Capacitance Characteristics

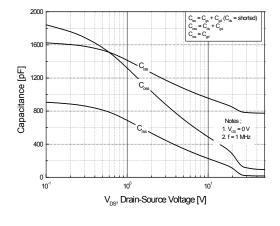


Figure 2. Transfer Characteristics

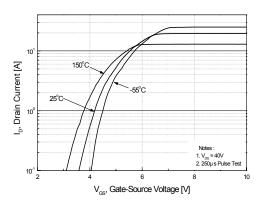


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

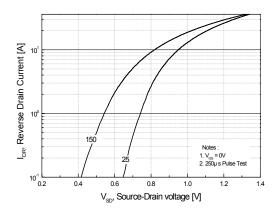
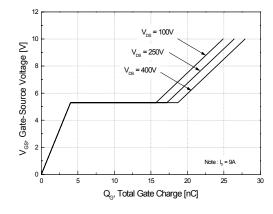


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

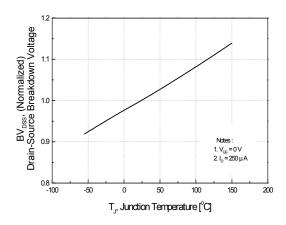


Figure 9. Maximum Safe Operating Area

Figure 8. On-Resistance Variation vs. Temperature

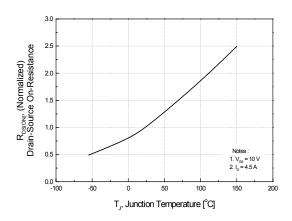


Figure 10. Maximum Drain Current vs. Case Temperature

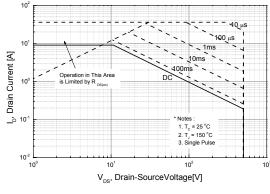
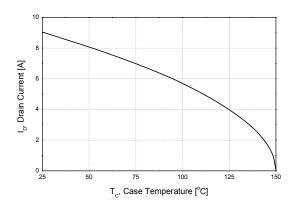
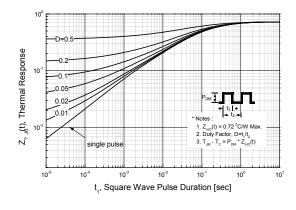


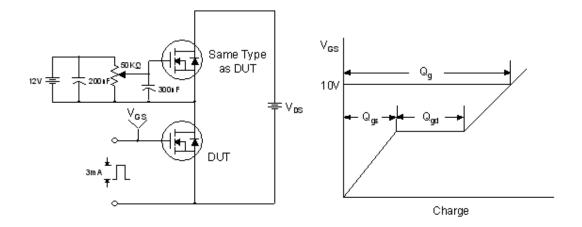
Figure 11. Transient Thermal Response Curve



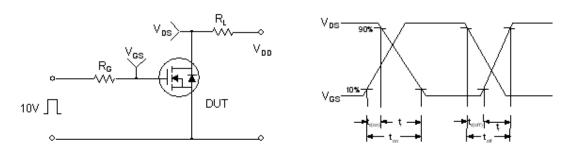


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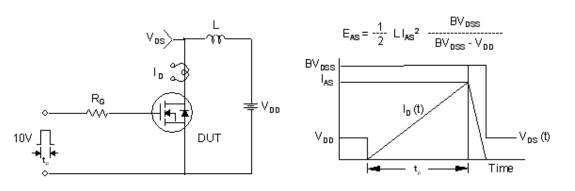
Gate Charge Test Circuit & Waveform

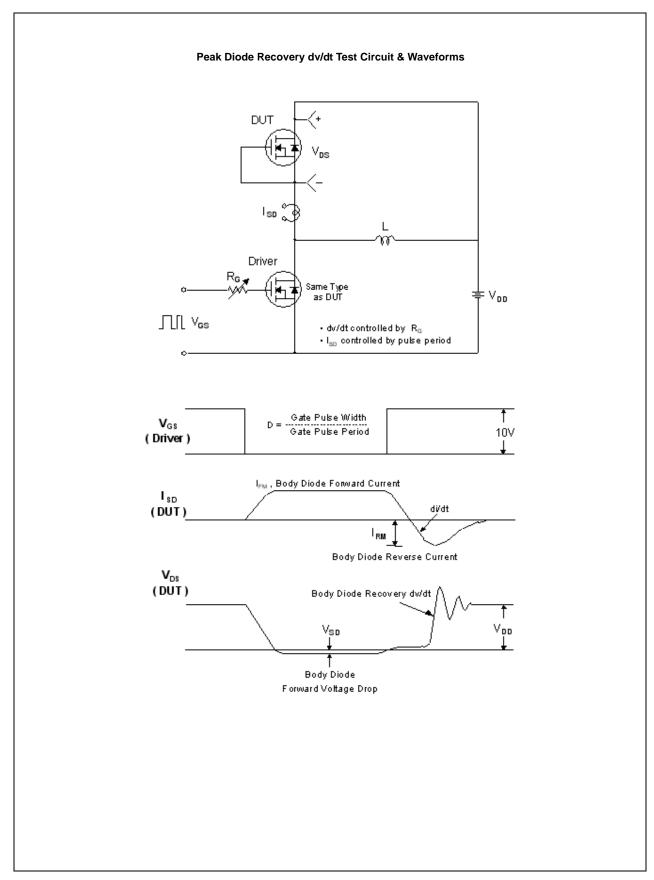


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms





Mechanical Dimensions D2-PAK -A-10.67 9.65 _1.68 _1.00 9.50 MIN 9.65 8.38 9.00 MIN 1.78 MAX 10.00 2 3 4.00 MIN (2.12) --1.50 MIN → 0.25 M B AM 5.08 **-** 5.08 **-**LAND PATTERN RECOMMENDATION -B-4.83 4.06 - 6.22 MIN -1.65 1.14 6.86 MIN 15.88 14.61 SEE DETAIL A NOTES: UNLESS OTHERWISE SPECIFIED A) ALL DIMENSIONS ARE IN MILLIMETERS. B) REFERENCE JEDEC, TO-263, ISSUE D, VARIATION AB, DATED JULY 2003. C) DIMENSIONING AND TOLERANCING PER ANSI Y14.5M - 1982. D) LOCATION OF THE PIN HOLE MAY VARY (LOWER LEFT CORNER, LOWER CENTER AND CENTER OF THE PACKAGE). B) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL. GAGE PLANE 0.74 0.33 0.25 △ 0.10 B - 2.79 1.78 0.25 MAX (5.38)SEATING PLANE DETAIL A, ROTATED 90° TO263A02REVD Dimensions in Millimeters

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